

IEEE Aerospace Electronic Systems VP-Conferences

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2022 BoG Meeting (New York, NY) 25 March 2022





- Enable high quality conferences/symposia/workshops
- Produce high quality technical content
- Facilitate the production of reasonable surpluses without sacrificing quality
- Refine and promote Best Practices in planning and managing conferences^{*}
- Explore new conference delivery mechanisms*

* Virtual and Hybrid events present significant challenges and will impact in-person attendance



SWOT



- Strengths
 - Several flagship conferences (Aerospace, AUTOTESTCON, Radar) that are high quality, well attended, and provide excellent surpluses
- Weaknesses
 - Relationships between Conference Organizing Committees and AESS not always as tight as they should be
 - Relationship with Conference Chairs not always as strong as they should be
 - Processes for FCS and TCS are not as clearly defined as they should be
 - AESS conference guidelines are not easily accessible at times confusing
 - Conference final reports are not always generated on time
- Opportunities
 - Steady-state regarding hybrid (in-person + virtual) conferences not reached yet
- Threats
 - Competition for conference attendees' time and money is intense



Projects



- Strengthen student participation
 - Graduate, undergraduate, and high-school level sessions and competitions
- Revive "Junior Conference Concept"
 - To coincide with major conference (Aerospace, Radar...
 - Offer awards/gifts for participation



Collaboration Opportunities

- Work with Tech_Ops committee to identify common areas with other societies
- Encourage panel chairs to work with conference chairs to identify technical tracks of mutual interest to other societies
 - Organize joint technical sessions, workshops, and tutorials
 - Organize invited sessions to draw top speakers from different communities





- None
- Set aside "seed funding" for under-developed/under-privileged regions/areas
 - Encourage participation and membership enrolment
 - To coincide with DL series

